

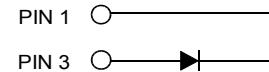
High Temperature Silicon Carbide Power Schottky Diode

V_{RRM}	=	650 V
V_F	=	1.5 V
I_F	=	15 A
Q_C	=	66 nC

Features

- 650 V Schottky rectifier
- 250 °C maximum operating temperature
- Zero reverse recovery charge
- Superior surge current capability
- Positive temperature coefficient of V_F
- Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F
- Available screened to Mil-PRF-19500

Package



SMD0.5 / TO – 276 (Hermetic Package)

Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- High Temperature DC/DC Converters
- High Temperature Motor and Servo Drives
- High Temperature Inverters
- High Temperature Actuator Control
- Military Power Supplies

Maximum Ratings at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V _{RRM}		650	V
Continuous forward current	I _F	T _C ≤ 225 °C	14.6	A
RMS forward current	I _{F(RMS)}	T _C ≤ 225 °C	26	A
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T _C = 25 °C, t _p = 10 ms	140	A
Non-repetitive peak forward current	I _{F,max}	T _C = 25 °C, t _p = 10 μs	650	A
I ² t value	$\int I^2 dt$	T _C = 25 °C, t _p = 10 ms	98	A ² s
Power dissipation	P _{tot}	T _C = 25 °C	453	W
Operating and storage temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V _F	I _F = 15 A, T _j = 25 °C	1.5	2.2		V
		I _F = 15 A, T _j = 210 °C	2.2			
Reverse current	I _R	V _R = 650 V, T _j = 25 °C	1	50	200	μA
		V _R = 650 V, T _j = 250 °C	50			
Total capacitive charge	Q _C	I _F ≤ I _{F,MAX}	66			nC
Switching time	t _s	dI _F /dt = 200 A/μs	V _R = 400 V	66		
		T _j = 210 °C	V _R = 400 V	< 49		ns
Total capacitance	C	V _R = 1 V, f = 1 MHz, T _j = 25 °C	V _R = 400 V, f = 1 MHz, T _j = 25 °C	1107	pF	
		V _R = 400 V, f = 1 MHz, T _j = 25 °C	V _R = 650 V, f = 1 MHz, T _j = 25 °C	103		
		V _R = 650 V, f = 1 MHz, T _j = 25 °C		99		

Thermal Characteristics

Thermal resistance, junction - case	R _{thJC}	0.49	°C/W
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Mechanical Properties

Mounting torque	M	0.6	Nm
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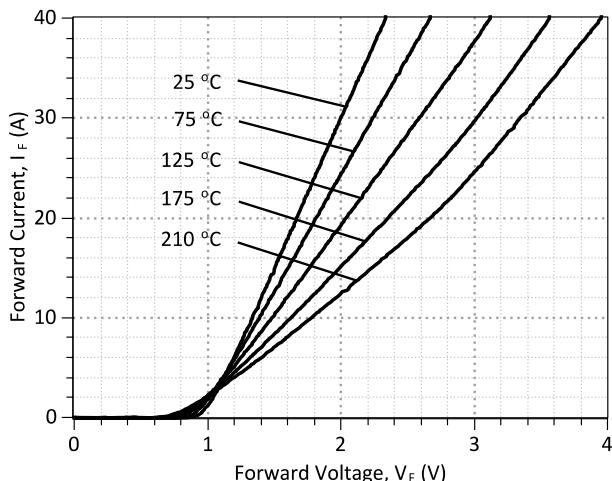


Figure 1: Typical Forward Characteristics

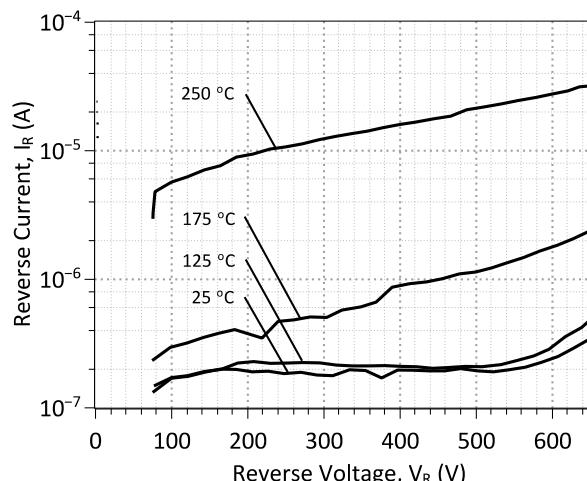


Figure 2: Typical Reverse Characteristics

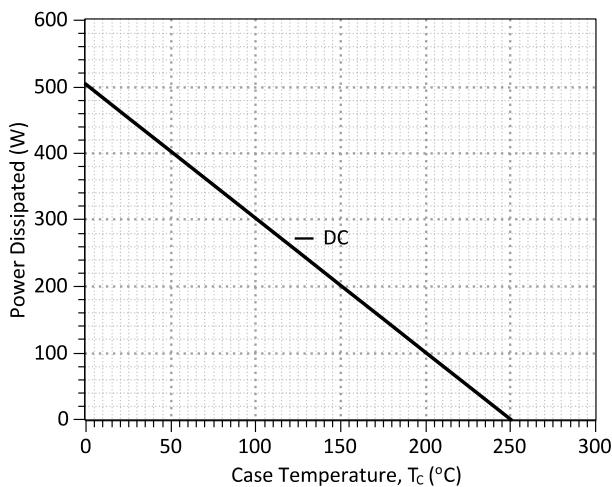


Figure 3: Power Derating Curve

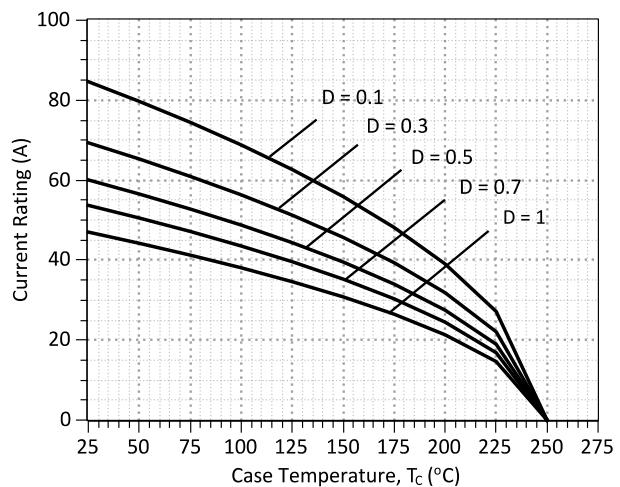


Figure 4: Current Derating Curves ($D = t_p/T$, $t_p = 400 \mu s$)
 (Considering worst case Z_{th} conditions)

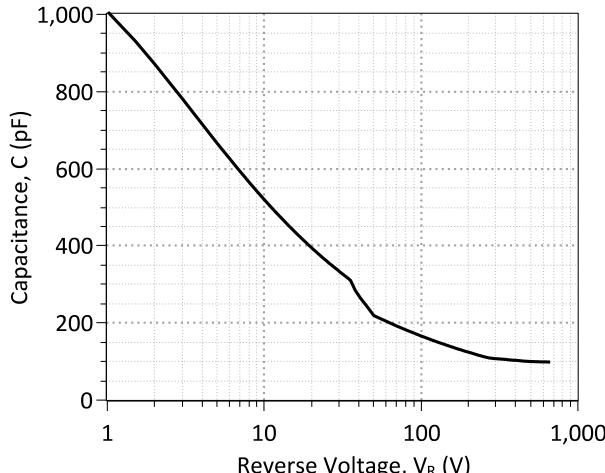


Figure 5: Typical Junction Capacitance vs Reverse Voltage Characteristics

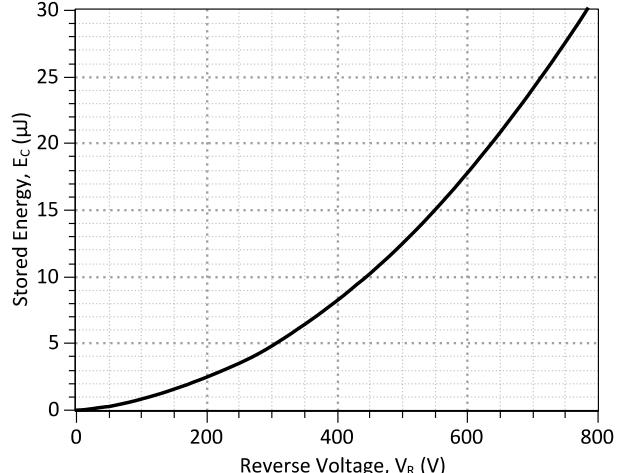


Figure 6: Typical Switching Energy vs Reverse Voltage Characteristics

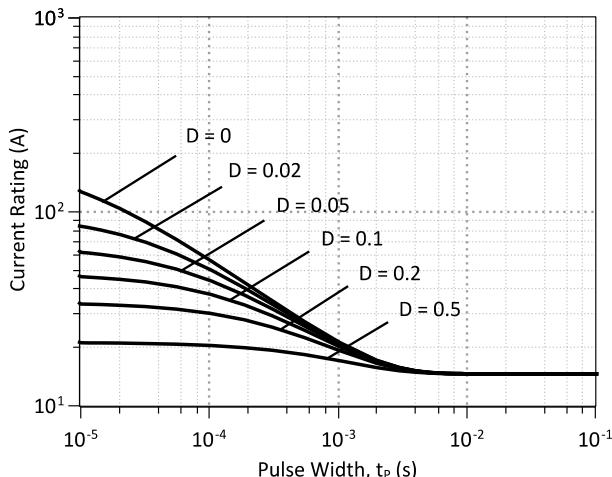


Figure 7: Current vs Pulse Duration Curves at $T_c = 225 \text{ } ^\circ\text{C}$

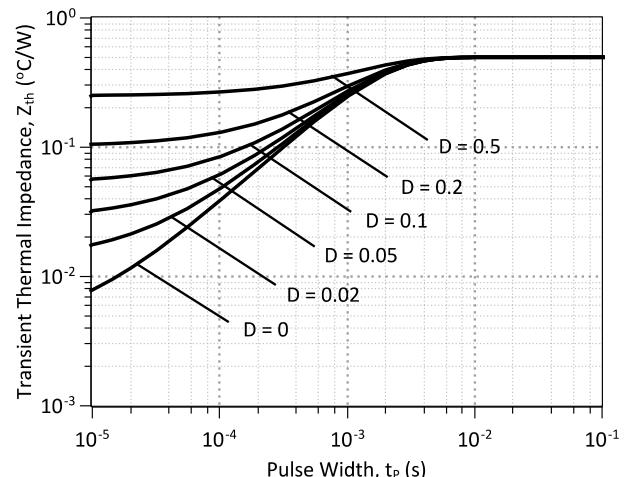
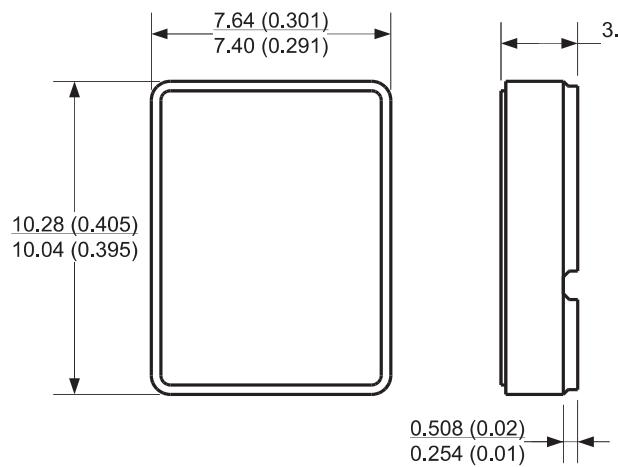


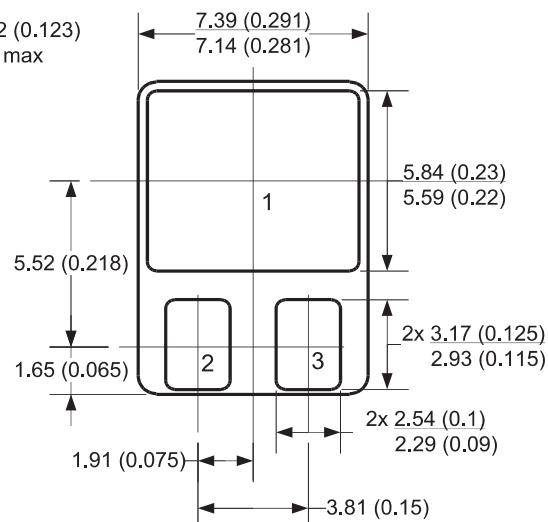
Figure 8: Transient Thermal Impedance

Package Dimensions:

SMD-0.5/TO-276



PACKAGE OUTLINE



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2013/11/13	1	Updated Electrical Characteristics	
2012/04/24	0	Initial release	

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the 1N8035-GA device.

```
* MODEL OF GeneSiC Semiconductor Inc.  
*  
* $Revision: 1.0      $  
* $Date: 05-SEP-2013 $  
*  
* GeneSiC Semiconductor Inc.  
* 43670 Trade Center Place Ste. 155  
* Dulles, VA 20166  
* http://www.genesicsemi.com/index.php/hit-sic/schottky  
*  
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*  
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY  
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED  
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A  
* PARTICULAR PURPOSE."  
* Models accurate up to 2 times rated drain current.  
*  
* Start of 1N8035-GA SPICE Model  
*.SUBCKT 1N8035 ANODE KATHODE  
D1 ANODE KATHODE 1N8035_25C; Call the Schottky Diode Model  
D2 ANODE KATHODE 1N8035_PIN; Call the PiN Diode Model  
.MODEL 1N8035_25C D  
+ IS      8.46E-17      RS      0.0319  
+ N       1              IKF     1000  
+ EG      1.2            XTI     3  
+ TRS1    0.0038        TRS2    3.00E-05  
+ CJO     1.26E-09      VJ      0.438  
+ M       1.5278         FC      0.5  
+ TT      1.00E-10       BV      650  
+ IBV    1.00E-03       VPK     650  
+ IAVE    20             TYPE    Sic_Schottky  
+ MFG     GeneSiC_Semiconductor  
.MODEL 1N8035_PIN D  
+ IS      2.77E-10      RS      0.086693  
+ N       3.3505         IKF    3.67E-06  
+ EG      3.23           XTI    -10  
+ FC      0.5            TT      0  
+ BV      650            IBV    1.00E-03  
+ VPK    650             IAVE    20  
+ TYPE   Sic_Pin  
.ENDS  
*  
* End of 1N8035-GA SPICE Model
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